

# P-Channel 60 V (D-S) MOSFET

| PRODUCT SUMMARY     |                                 |                                 |                       |  |  |
|---------------------|---------------------------------|---------------------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | R <sub>DS(on)</sub> (mΩ)(Typ.)  | I <sub>D</sub> (A) <sup>a</sup> | Q <sub>g</sub> (Typ.) |  |  |
| - 60                | 50 at V <sub>GS</sub> = - 10 V  | - 12                            | 20 nC                 |  |  |
| - 00                | 60 at V <sub>GS</sub> = - 4.5 V | - 12                            | 20 nC                 |  |  |

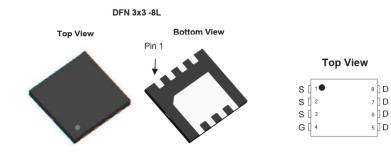
#### **FEATURES**

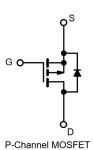


- DT-Trench Power MOSFET
- Low On-Resistance for Low Voltage Drop
- 100 %  $R_{\rm g}$  and UIS Tested

#### **APPLICATIONS**

- Battery, Load and Adaptor Switches
  - Notebook Computers
  - Notebook Battery Packs





| ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted) |                                   |                 |                     |   |  |
|---|-----------------------------------|-----------------|---------------------|---|--|
| Parameter   |                                   |                 | Limit               | Unit                                    |  |
| Drain-Source Voltage  |                                   | V <sub>DS</sub> | - 60                | V                                       |  |
| Gate-Source Voltage   |                                   |                 | ± 20                | \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \   |  |
| Continuous Drain Current (T <sub>.1</sub> = 150 °C)                       | T <sub>C</sub> = 25 °C            | l <sub>a</sub>  | - 12                |   |  |
| Continuous Brain Current (1) = 100 C)                                     | T <sub>C</sub> = 70 °C            | l <sub>D</sub>  | - 9                 | Α                                       |  |
| Pulsed Drain Current  | I <sub>DM</sub>                   | - 48            |                     |   |  |
| Single-Pulse Avalanche Energy   |                                   | E <sub>AS</sub> | 15                  | mJ                                      |  |
|   | T <sub>C</sub> = 25 °C            | P <sub>D</sub>  | 42                  |   |  |
| Maximum Power Dissipation   | T <sub>C</sub> = 70 °C            |                 | 27                  | $\Box$ w                                |  |
| Maximum Tower Dissipation   | T <sub>A</sub> = 25 °C            |                 | 3.2 <sup>b,c</sup>  | • |  |
|   | T <sub>A</sub> = 70 °C            |                 | 2.05 <sup>b,c</sup> |   |  |
| Operating Junction and Storage Temperature Range                          | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150     | °C                  |   |  |

| THERMAL RESISTANCE RATINGS               |              |                   |         |      |      |  |
|--|--------------|-------------------|---------|------|------|--|
| Parameter                                | Symbol       | Typical           | Maximum | Unit |      |  |
| Maximum Junction-to-Ambient <sup>c</sup> | t ≤ 10 s     | R <sub>thJA</sub> | 35      | 39   | °C/W |  |
| Maximum Junction-to-Case                 | Steady State | R <sub>thJC</sub> | 2.5     | 2.97 | C/VV |  |

### Notes:

- a. Based on  $T_C$  = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.



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| Parameter                                     | Symbol  | Test Conditions   | Min.     | Тур.     | Max.     | Unit |  |
|---|---|---|----------|----------|----------|------|--|
| Static  |   |   | <u>'</u> | <u>'</u> | <u>'</u> |      |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>   | V <sub>GS</sub> = 0, I <sub>D</sub> = - 250 μA                            | - 60     |          |          | V    |  |
| Gate-Source Threshold Voltage                 | V <sub>G</sub> S(th)  | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$                                     | - 1.2    |          | - 2.2    | V    |  |
| Gate-Source Leakage                           | I <sub>GSS</sub>  | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                         |          |          | ± 100    | nA   |  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>  | V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V                           |          |          | - 1      | ^    |  |
| Zero Gate Voltage Drain Guiterit              |   | V <sub>DS</sub> = - 60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C   |          |          | - 5      | μA   |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>  | $V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$                         | - 12     |          |          | Α    |  |
| Duning Courses On Otata Danistana a           | В   | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A                          | 50 56    |          | 56       | _    |  |
| Drain-Source On-State Resistance <sup>a</sup> | $R_{DS(on)}$  | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5 A                         |          | 60       | 67       | mΩ   |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>   | V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 5 A                          |          | 20       |          | S    |  |
| Dynamic <sup>b</sup>                          |   |   | •        |          |          |      |  |
| Input Capacitance                             | C <sub>iss</sub>  |   |          | 1110     |          | pF   |  |
| Output Capacitance                            | C <sub>oss</sub>  | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$         |          | 65       |          |      |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>  | 1   |          | 50       |          |      |  |
| Total Gate Charge                             | Q <sub>g</sub>  |   |          | 20       |          |      |  |
| Gate-Source Charge                            | Q <sub>gs</sub>   | $V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -5 \text{ A}$    |          | 8.6      |          | nC   |  |
| Gate-Drain Charge                             | Q <sub>gd</sub>   | 1   |          | 28       |          |      |  |
| Gate Resistance                               | R <sub>g</sub>  | f = 1 MHz   |          | 15       |          | Ω    |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>  |   |          | 11       |          |      |  |
| Rise Time                                     | t <sub>r</sub>  | $V_{DD} = -30 \text{ V, R}_{L} = 3.5 \Omega$                              |          | 9        |          | ns   |  |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>   | $I_D \cong$ - 5 A, V <sub>GEN</sub> = - 10 V, R <sub>g</sub> = 1 $\Omega$ |          | 27       |          |      |  |
| Fall Time                                     | t <sub>f</sub>  | 7   |          | 6        |          |      |  |
| Drain-Source Body Diode Characterist          | ics   |   |          |          |          |      |  |
| Continous Source-Drain Diode Current          | Is  | T <sub>C</sub> = 25 °C  |          |          | - 12     | Α    |  |
| Pulse Diode Forward Current (100 μs)          | I <sub>SM</sub>   |   |          |          | - 48     | 1 ^  |  |
| Body Diode Voltage                            | V <sub>SD</sub>   | I <sub>S</sub> = - 1 A  |          | - 0.6    | - 1.2    | V    |  |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>   |   |          | 21       |          | ns   |  |
| Body Diode Reverse Recovery Charge            | everse Recovery Charge $Q_{rr}$ $I_F = -5 \text{ A}, \text{ dI/dt} = 100 \text{ A/µs}, T_J = 25 ^\circ$ |   |          | 50       |          | nC   |  |
| Reverse Recovery Fall Time                    | ta  | - 1F 3 A, αl/αι - 100 A/μs, 1 <sub>J</sub> = 25 C                         |          | 9        |          | ns   |  |
| Reverse Recovery Rise Time                    | t <sub>b</sub>  | 1   |          | 14       |          |      |  |

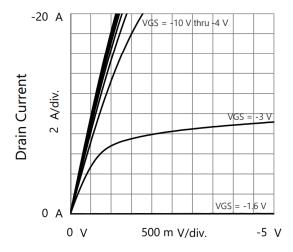
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

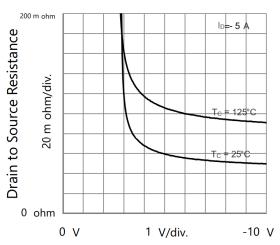
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$  b. Guaranteed by design, not subject to production testing.



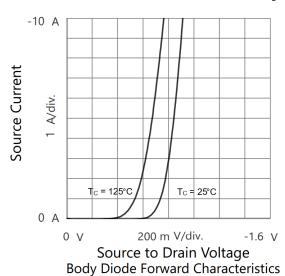
### TYPICAL CHARACTERISTICS (25 C, unless otherwise noted)

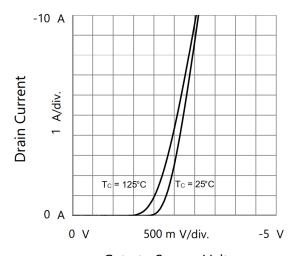


Drain to Source Voltage Output Characteristics

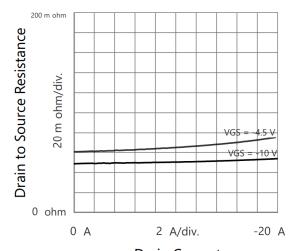


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

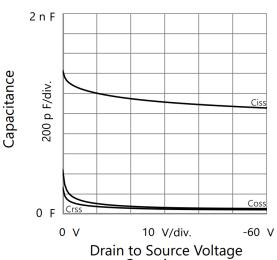




Gate to Source Voltage Transfer Characteristics



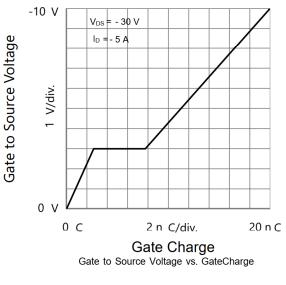
Drain Current
Drain to Source Resistance vs. Drain Current

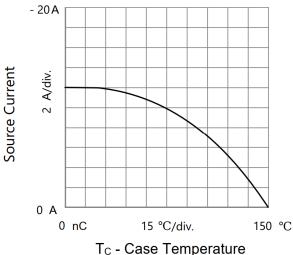


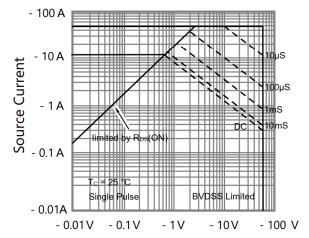
Capacitances



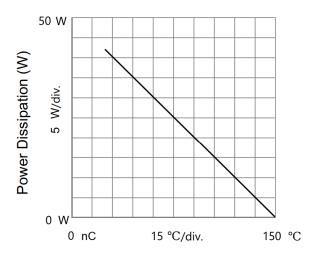
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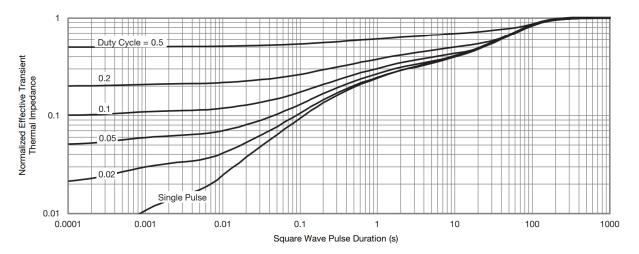




Source to Drain Voltage Safe Operating Area, Junction-to-Ambient



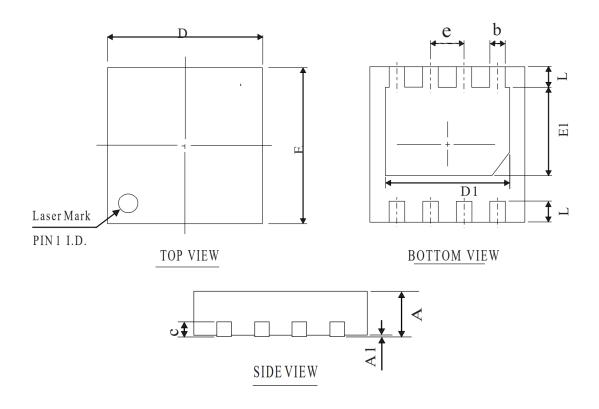
T<sub>C</sub> - Case Temperature



Normalized Thermal Transient Impedance, Junction-to-Case



## DFN3\*3-8L PACKAGE OUTLINE



## **COMMON DIMENSIONS** (UNITS OF MEASURE=mm)

| SYMBOL | MIN        | NOM  | MAX   |
|--------|------------|------|-------|
| A      | 0. 60      | 0.75 | 0. 90 |
| A1     | 0. 00      | 0.02 | 0. 08 |
| ь      | 0. 20      | 0.30 | 0.45  |
| D      | 2.85       | 3.00 | 3. 15 |
| Е      | 2. 85      | 3.00 | 3. 15 |
| D1     | 2. 10      | 2.40 | 2.70  |
| E1     | 1.50       | 1.70 | 2. 00 |
| L      | 0. 20      | 0.40 | 0.60  |
| С      | 0. 203 REF |      |       |
| e      | 0. 65 BSC  |      |       |

## OTHER DIMENSIONS

| A | 0. 50 | 0.55  | 0.60 |
|---|-------|-------|------|
| A | 0.40  | 0. 45 | 0.50 |

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